

1.8V CMOS Low Jitter Crystal Clock Oscillator (XO)





Actual Size $= 3.2 \times 5$ mm



Product Features

- Less than 1.5 ps RMS jitter with fundamental or overtone design
- 1.8V CMOS compatible logic levels
- Pin-compatible with standard 3.2x5mm packages
- Designed for standard reflow and washing techniques
- Low power standby mode: 10 uA max
- Pb-free and RoHS/Green compliant

Product Description

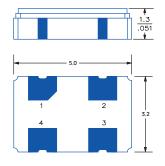
The \$1632 Series is a 1.8V crystal clock oscillator that achieves superb jitter and stability over a broad range of operating conditions and frequencies. The output clock signal, generated internally with a non-PLL oscillator design, is compatible with LVCMOS logic levels. The device, available on tape and reel, is contained in a 3.2x5mm surface-mount ceramic package.

Applications

The \$1632 Series is an ideal reference clock for compact, high-density applications requiring low jitter tight stability, or low power consumption, including:

- Ethernet
- HBA
- Portable Multimedia Player (PMP)
- Notebook Computer
- Hard Disk Drive

Packaging Outline



Pin Functions

Pin	Function
1	OE Function
2	Ground
3	Clock Output
4	V_{DD}

Common Frequencies

 $B = \pm 50 \text{ ppM (-10 to } +70 ^{\circ}\text{C)}$ *E = $\pm 50 \text{ ppM (-40 to } +85 ^{\circ}\text{C)}$

Contact SaRonix for additional frequencies 24.0000 MHz 2.0480 MHz 50.0000 MHz 3.6864 MHz 24.5760 MHz 60.0000 MHz 8.0000 MHz 25.0000 MHz 66.0000 MHz 10.0000 MHz 27.0000 MHz 66.6667 MHz 14.3181 MHz 32.0000 MHz 75.0000 MHz 16.0000 MHz 33.0000 MHz 80.0000 MHz 90.0000 MHz 19.4400 MHz 40.0000 MHz 20.0000 MHz 48.0000 MHz 100.0000 MHz

^{*} Availability varies by frequency.





Electrical Performance

Po	ırameter	Min.	Тур.	Max.	Units	Notes
Output frequen	ncy	1.5440		100	MHz	As specified
Supply voltage		1.71	1.8	1.89	V	
				4		1.5440 to <36 MHz
C				7	4	36 to <50 MHz
Supply current	t, output enabled			10	mA	50 to <70 MHz
				20		70 to 100 MHz
Standby current				10	μА	1.5440 to <36MHz
ľ				100	uA	36 to 100MHz
Frequency stat	oility			±25 to ±50	ppM	See Note 1 below
Operating tem	Operating temperature			+85	°C	As specified
Output logic 0,	Output logic 0, VOL			10% V _{DD}	V	
Output logic 1, VOH		90% V _{DD}			V	
Output load		15 pF (max)				
Duty cycle		45		55	%	measured 50%VDD
Rise and fall	<36 MHz			4		measured 20/80% of waveform
time	36 to 100 MHz			2.5	ns	measured 20/80% of waveform
Jitter,	up to 75 MHz			1.5	ps RMS (1-σ)	10kHz to 20 MHz frequency band
Phase	75 to 100 MHz			1		
Jitter,	up to <75 MHz			5	ps RMS (1-σ)	20.000 adjacent periods
Accumulated	75 to 100 MHz			3		
Jitter,	up to <75 MHz			50	ps	100.000 random periods
Total	75 to 100 MHz			30	pk-pk	

Notes:

Output Enable / Disable Function

Parameter	Min.	Тур.	Max.	Units	Notes
Input Voltage (pin 1), Output Enable	0.7 V _{DD}			V	or open
Input voltage (pin 1), Output Disable (low power standby)			0.3 V _{DD}	V	Output is Hi-Z
Internal pullup resistance	30			kΩ	
Output disable delay			200	ns	
Output enable delay			10	ms	



^{1.} As specified. Stability includes all combinations of operating temperature, load changes, rated input (supply) voltage changes, initial calibration tolerance (25°C), aging (1 year at 25°C average effective ambient temperature), shock and vibration.

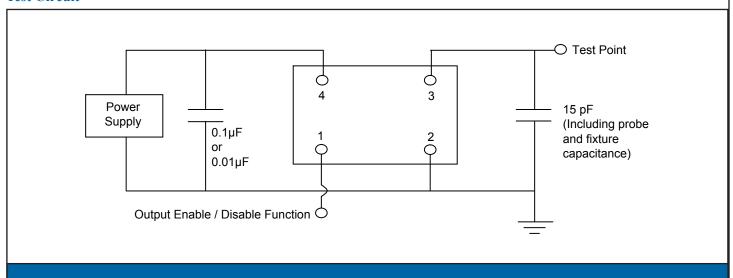


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Absolute Maximum Ratings

Parameter	Min.	Тур.	Max.	Units	Notes
Storage temperature	-55		+125	°C	

Test Circuit



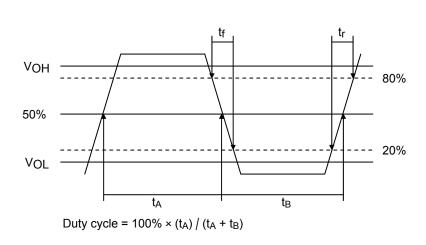
Reliability Test Ratings

This product is rated to meet the following test conditions:

Туре	Parameter	Test Condition
Mechanical	Shock	MIL-STD-883, Method 2002, Condition B
Mechanical	Solderability	JESD22-B102-D Method 2 (Preconditioning E)
Mechanical	Terminal strength	MIL-STD-883, Method 2004, Condition D
Mechanical	Gross leak	MIL-STD-883, Method 1014, Condition C
Mechanical	Fine leak	MIL-STD-883, Method 1014, Condition A2 ($R_1 = 2x10^{-8}$ atm cc/s)
Mechanical	Solvent resistance	MIL-STD-202, Method 215
Environmental	Thermal shock	MIL-STD-883, Method 1011, Condition A
Environmental	Moisture resistance	MIL-STD-883, Method 1004
Environmental	Vibration	MIL-STD-883, Method 2007, Condition A
Environmental	Resistance to soldering heat	J-STD-020C Table 5-2 Pb-free devices (2 cycles max)

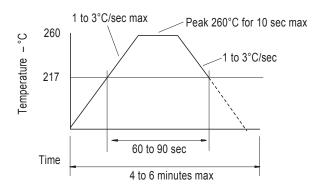






Reflow Soldering Profile

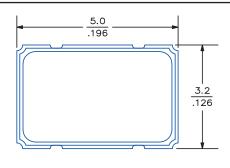
As per IPC/JEDEC J-STD-020C



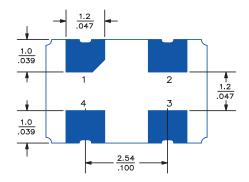


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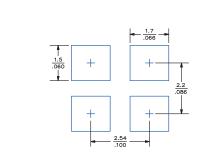
Mechanical Drawings







Recommended Land Pattern*



*External high-frequency power decoupling is recommended.(see test circuit for minimum recommendation). To ensure optimal performance, do not route traces beneath the package.

Scale: None. Dimensions are in mm/inches.

Marking LINE 1: Marking LINE 2: S 2 X

(SaRonix, Model, Stability code)

Frequency (Frequency code)

Marking LINE 3: ● YY WW X

(Pin 1, Year, Week, Origin)

**Exact location of markings may vary.